Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/717,249	EVANS, MARTIN	
Examiner	Art Unit	
Dandy Bayes	4764	

SEARCHED			
Class	Subclass	Date	Examiner
208	113	12/15/2006	RB
208	152	12/15/2006	RB
222	141	12/15/2006	RB
422	139	12/15/2006	RB
· 422	145	12/15/2006	RB
422	219	12/15/2006	RB
422	239	12/15/2006	RB
422	297	12/15/2006	RB
422	300	12/15/2006	RB
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
See EAST Search History	12/20/2006	RB
Keyword searching in all of Class 414	12/15/2006	RB
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